

# **600V Super-Junction Power MOSFET**

#### **FEATURES**

- $\bullet \quad \text{Very low FOM R}_{\text{DS(on)}} \times \text{Q}_{\text{g}} \\$
- 100% avalanche tested
- RoHS compliant

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



Device Marking and Package Information					
Device	TPA60R3K4C	TPP60R3K4C	TPU60R3K4C	TPD60R3K4C	
Package	TO-220F	TO-220	TO-251	TO-252	
Marking	60R3K4C	60R3K4C	60R3K4C	60R3K4C	

<b>Absolute Maximum Ratings</b> $T_C = 25^{\circ}C$ , unless otherwise noted					
Parameter		Symbol	Value		l locit
			TO-220,TO-251,TO-252	TO-220F	Unit
Drain-Source Voltage (V <sub>GS</sub> = 0V)		V <sub>DSS</sub>	600		V
Continuous Drain Current	I <sub>D</sub> 1.4		А		
Pulsed Drain Current	(note1)	I <sub>DM</sub>	4.2		А
Gate-Source Voltage		$V_{GSS}$	±30		V
Single Pulse Avalanche Energy	(note2)	E <sub>AS</sub>	1.25		mJ
Avalanche Current	(note1)	I <sub>AR</sub>	0.5		А
Repetitive Avalanche Energy (note1)		E <sub>AR</sub>	0.03		mJ
Power Dissipation (T <sub>C</sub> = 25°C)		P <sub>D</sub>	12.3	6	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55~+150		°C

Thermal Resistance					
Parameter	Symbol	Value		Unit	
Parameter	Symbol	TO-220,TO-251,TO-252	TO-220F	Unit	
Thermal Resistance, Junction-to-Case	R <sub>thJC</sub>	10.2	20.8	12/\\	
Thermal Resistance, Junction-to-Ambient	R <sub>thJA</sub>	62	80	K/W	

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## TPA60R3K4C,TPP60R3K4C,TPU60R3K4C,TPD60R3K4C

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<b>Specifications</b> $T_J = 25^{\circ}C$ , un	iless othe	rwise noted			-	
Parameter	Symbol Test Conditions	Value			Unit	
- aramoto	Test conditions		Min.	Тур.	Max.	
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	600			٧
Zero Gate Voltage Drain Current		$V_{DS} = 600V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 600V, V_{GS} = 0V, T_{J} = 150^{\circ}C$			100	μΑ
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 30V$			±100	nA
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.0	V
Drain-Source On-Resistance (Note3)	R <sub>DS(on)</sub>	$V_{GS} = 10V, I_{D} = 0.7A$		2.8	3.4	Ω
Forward Transconductance (Note3)	9 <sub>fs</sub>	$V_{DS} = 10V, I_{D} = 0.7A$		1.0		S
Dynamic		•				
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0V$ ,		120		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 50V$ ,		25		
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0MHz		5		
Total Gate Charge	$Q_g$			4.1		nC
Gate-Source Charge	$Q_{gs}$	$V_{DD} = 480V, I_{D} = 1.4A,$ $V_{GS} = 10V$		0.7		
Gate-Drain Charge	$Q_{gd}$	65		2.5		
Turn-on Delay Time	t <sub>d(on)</sub>			49		
Turn-on Rise Time	t <sub>r</sub>	$V_{DD} = 400V, I_{D} = 1.4A,$		17		
Turn-off Delay Time	t <sub>d(off)</sub>	$R_G = 25\Omega$		24		ns
Turn-off Fall Time	t <sub>f</sub>			19		
Drain-Source Body Diode Characteris	stics			•		
Continuous Body Diode Current	I <sub>s</sub>	T 0500			1.4	Α
Pulsed Diode Forward Current	I <sub>SM</sub>	T <sub>C</sub> = 25°C			5.6	А
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = 1.4A$ , $V_{GS} = 0V$		0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>			76.6		ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_R = 400V, I_F = I_S,$ $di_F/dt = 100A/\mu s$		0.3		μC
Peak Reverse Recovery Current	I <sub>rrm</sub>			3.1		Α

#### **Notes**

- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2.  $I_{AS}$  = 0.5A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 1%





Figure 2. Transfer Characteristics

## **Typical Characteristics** $T_J = 25^{\circ}$ C, unless otherwise noted

Figure 1. Output Characteristics 4 3.5 20V 10V 3 I<sub>D</sub>, Drain Current (A) 6V 5.5V 2.5 5V 2 4.5V 1.5 1 0.5 6 8 10 18 0 12 14 16 V<sub>DS</sub>, Drain-to-Source Voltage (V)

3  $V_{DS} = 10V$ 2.5 I<sub>D</sub>, Drain Current (A) 2  $T_{J} = 25^{\circ}C$ 1.5  $T_J = 150^{\circ}C$ 0.5 0 0 2 6 8 10 V<sub>GS</sub>, Gate-to-Source Voltage (V)

Figure 3. On-Resistance vs. Drain Current

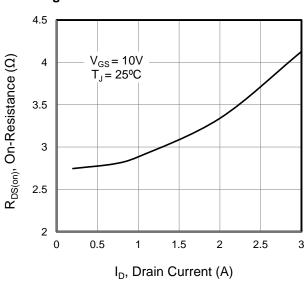


Figure 4. Capacitance

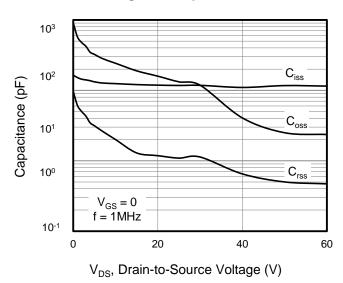


Figure 5. Gate Charge

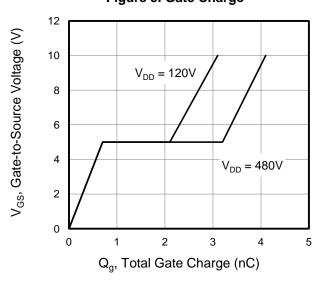
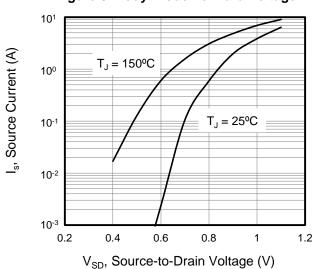


Figure 6. Body Diode Forward Voltage



## **Typical Characteristics** $T_J = 25^{\circ}C$ , unless otherwise noted

Figure 7. On-Resistance vs. Junction Temperature

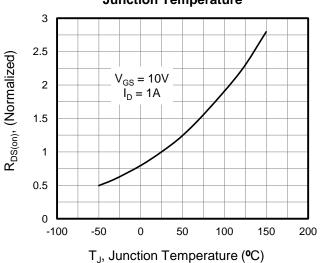


Figure 9. Transient Thermal Impedance TO-220/TO-251/TO-252

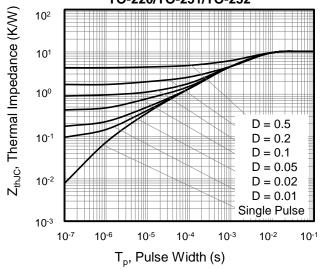
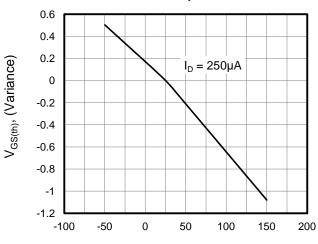


Figure 8. Threshold Voltage vs. Junction Temperature



T<sub>J</sub>, Junction Temperature (°C)

Figure 10. Transient Thermal Impedance TO-220F

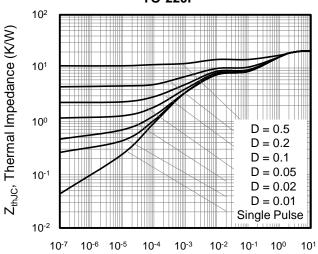




Figure A: Gate Charge Test Circuit and Waveform

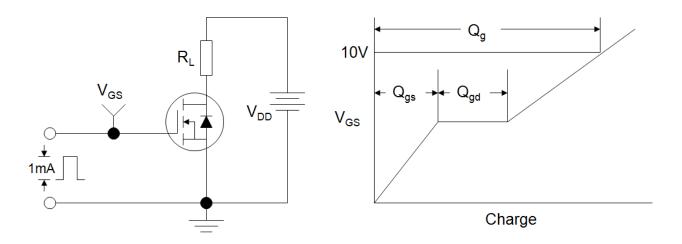


Figure B: Resistive Switching Test Circuit and Waveform

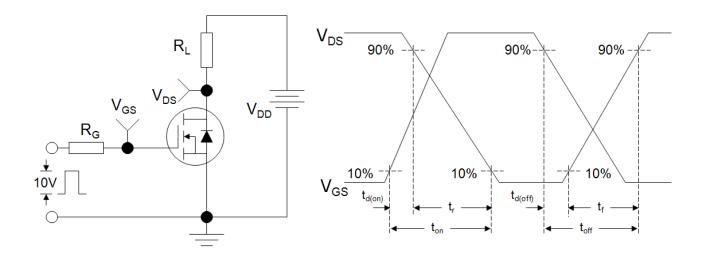
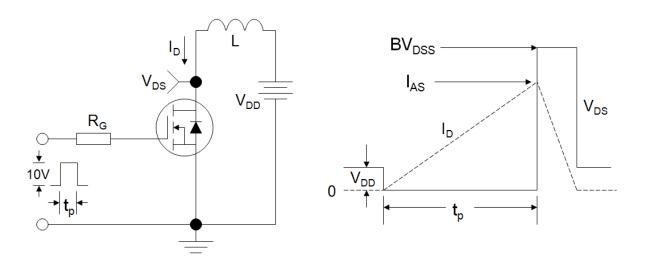
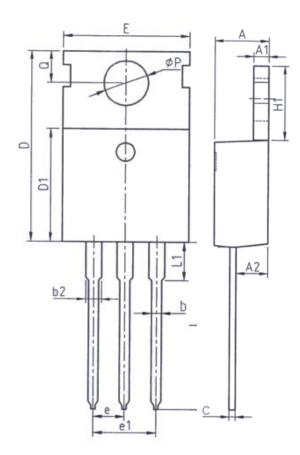


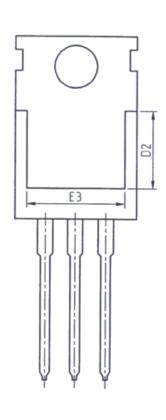
Figure C: Unclamped Inductive Switching Test Circuit and Waveform



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# **TO-220**

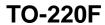


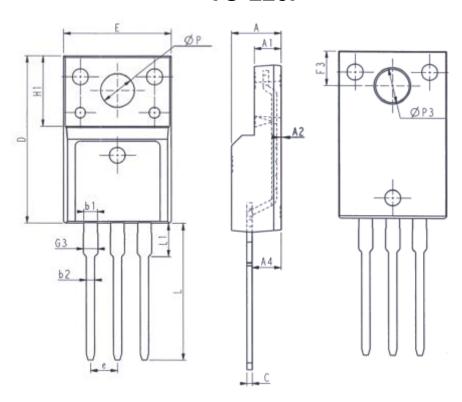


Unit: mm				
Symbol	Min.	Max.		
Α	4. 37	4. 77		
A1	1. 25	1. 45		
A2	2. 20	2. 60		
b	0. 70	0. 95		
b2	1. 17	1. 47		
С	0. 40	0. 65		
D	15. 10	16. 10		
D1	8. 80	9. 40		
D2	5. 50	_		

Unit: mm				
Symbol	Min.	Max.		
E	9. 70	10. 30		
E3	7. 00	_		
е	2. 54BSC			
e1	5. 08	BBSC		
H1	6. 25	6. 85		
L	12. 75	13.80		
L1	-	3. 40		
P	3. 40	3. 80		
Q	2. 60	3. 00		

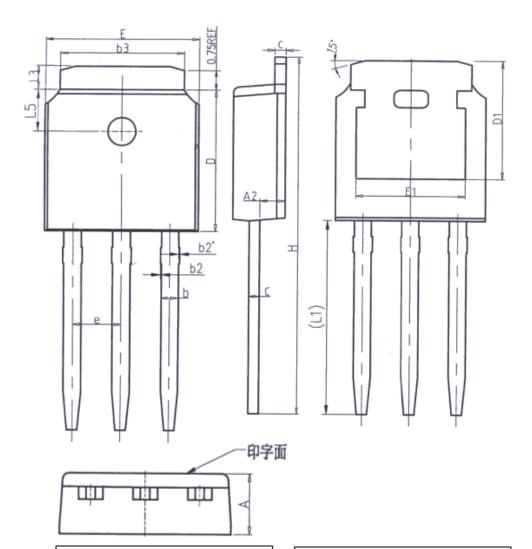






Unit: mm			l	Jnit: mm	1
Symbol	Min.	Max.	Symbol	Min.	Max.
E	9. 96	10. 36	L	12. 68	13. 28
Α	4. 50	4. 90	L1	2. 93	3. 13
<b>A</b> 1	2. 34	2. 74	Р	3. 03	3. 38
A2	0. 30	0.60	Р3	3. 15	3. 65
A4	2. 56	2. 96	F3	3. 15	3. 45
С	0. 40	0. 65	G3	1. 25	1. 55
D	15. 57	16. 17	b1	1. 18	1. 43
H1	6. 70	6. 70REF		0. 70	0. 95
e	2. 54BSC				

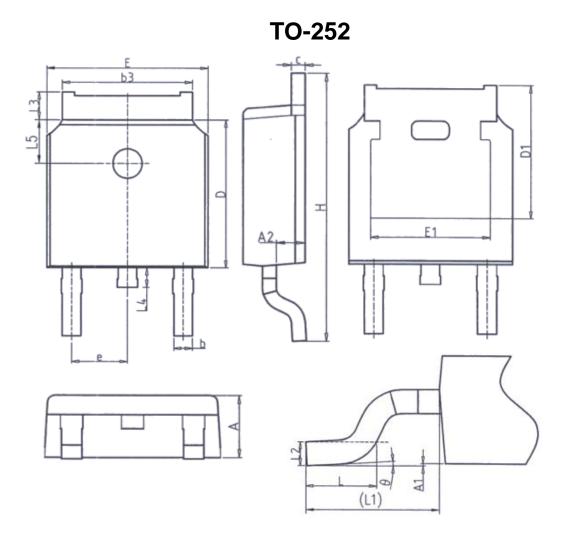
# **TO-251**



Unit: mm				
Symbol	Min.	Max.		
Α	2. 20	2. 40		
A2	0. 97	1. 17		
b	0. 68	0. 90		
b2	0.00	0.10		
b2′	0.00	0.10		
b3	5. 20	5. 50		
С	0. 43	0. 63		
D	5. 98	6. 22		

Unit: mm				
Symbol	Min.	Max.		
D1	5. 30REF			
E	6. 40	6. 80		
E1	4. 63	-		
е	2. 286BSC			
Н	16. 22	16. 82		
L1	9. 15	9. 65		
L3	0.88	1. 28		
L5	1. 65	1. 95		





Unit: mm					
Symbol	Min.	Max.			
Α	2. 20	2. 40			
A1	0.00	0. 20			
A2	0. 97	1. 17			
b	0. 68	0. 90			
b3	5. 20	5. 50			
С	0.43	0. 63			
D	D 5. 98 6. 22				
D1	D1 5. 30REF				
E	6. 40	6. 80			
E1	4. 63	_			

Unit: mm				
Symbol	Min. Max.			
е	2. 286BSC			
Н	9. 40	10.50		
L	1. 38	1. 75		
L1	L1 2. 90REF			
L2	0. 51	IBSC		
L3	0.88	1. 28		
L4	- 1.00			
L5	1. 65	1. 95		
θ	0°	8°		

#### TPA60R3K4C,TPP60R3K4C,TPU60R3K4C,TPD60R3K4C



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